

# MBN1500E33E2

Silicon N-channel IGBT 3300V E2 version

## FEATURES

- \* Soft switching behavior & low conduction loss:  
Soft low-injection punch-through High conductivity IGBT.
- \* Low driving power due to low input capacitance MOS gate.
- \* Low noise recovery: Ultra soft fast recovery diode.
- \* High thermal fatigue durability:  
( $\Delta T_c=70K$ ,  $N>30,000$ cycles)  
AlSiC base-plate/AlN substrate

## ABSOLUTE MAXIMUM RATINGS ( $T_c=25^\circ\text{C}$ )

Item	Symbol	Unit	MBN1500E33E2
Collector Emitter Voltage	$V_{CES}$	V	3,300
Gate Emitter Voltage	$V_{GES}$	V	$\pm 20$
Collector Current	DC	A	1,500
	1ms		3,000
Forward Current	DC	A	1,500
	1ms		3,000
Operating Junction Temperature	$T_{vj,op}$	$^\circ\text{C}$	-40 ~ +150
Storage Temperature	$T_{stg}$	$^\circ\text{C}$	-50 ~ +125
Isolation Voltage	$V_{ISO}$	$V_{RMS}$	6,000(AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	2/15 (1)
	Mounting (M6)	-	6 (2)

Notes: (1) Recommended Value  $1.8 \pm 0.2/15^{+0}_{-3} \text{N}\cdot\text{m}$

(2) Recommended Value  $5.5 \pm 0.5 \text{N}\cdot\text{m}$

## ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	$I_{CES}$	mA	-	-	12	$V_{CE}=3,300\text{V}$ , $V_{GE}=0\text{V}$ , $T_{vj}=25^\circ\text{C}$
			-	20	60	$V_{CE}=3,300\text{V}$ , $V_{GE}=0\text{V}$ , $T_{vj}=125^\circ\text{C}$
Gate Emitter Leakage Current	$I_{GES}$	nA	-500	-	+500	$V_{GE}=\pm 20\text{V}$ , $V_{CE}=0\text{V}$ , $T_{vj}=25^\circ\text{C}$
Collector Emitter Saturation Voltage	$V_{CEsat}$	V	2.5	2.95	3.5	$I_C=1,500\text{A}$ , $V_{GE}=15\text{V}$ , $T_{vj}=125^\circ\text{C}$
			-	3.1	-	$I_C=1,500\text{A}$ , $V_{GE}=15\text{V}$ , $T_{vj}=150^\circ\text{C}$
Gate Emitter Threshold Voltage	$V_{GE(th)}$	V	5.5	6.3	7.5	$V_{CE}=10\text{V}$ , $I_C=1,500\text{mA}$ , $T_{vj}=25^\circ\text{C}$
Input Capacitance	$C_{ies}$	nF	-	195	-	$V_{CE}=10\text{V}$ , $V_{GE}=0\text{V}$ , $f=100\text{kHz}$ , $T_{vj}=25^\circ\text{C}$
Internal Gate Resistance	$R_{G(int)}$	$\Omega$	-	1.0	-	$V_{CE}=10\text{V}$ , $V_{GE}=0\text{V}$ , $f=100\text{kHz}$ , $T_{vj}=25^\circ\text{C}$
Turn On Delay Time	$t_{d(on)}$	$\mu\text{s}$	-	1.0	-	$V_{CC}=1,650\text{V}$ , $I_C=1,500\text{A}$
Rise Time	$t_r$		1.6	2.0	2.6	$L_S=100\text{nH}$
Turn Off Delay Time	$t_{d(off)}$		-	2.7	-	$R_G=2.7\Omega/2.7\Omega$ , $C_{GE}=330\text{nF}$ (3)
Fall Time	$t_f$		0.9	1.7	2.6	$V_{GE}=\pm 15\text{V}$ , $T_{vj}=125^\circ\text{C}$
Forward Voltage Drop	$V_F$	V	2.2	2.6	3.0	$I_F=1,500\text{A}$ , $V_{GE}=0\text{V}$ , $T_{vj}=125^\circ\text{C}$
			-	2.6	-	$I_F=1,500\text{A}$ , $V_{GE}=0\text{V}$ , $T_{vj}=150^\circ\text{C}$
Reverse Recovery Time	$t_{rr}$	$\mu\text{s}$	0.2	0.8	1.2	$V_{CC}=1,650\text{V}$ , $I_F=1,500\text{A}$ , $L_S=100\text{nH}$ $T_{vj}=125^\circ\text{C}$ , $R_G=2.7\Omega/2.7\Omega$ , $C_{GE}=330\text{nF}$ (3)
Short Circuit Pulse Width	$t_{sc}$	$\mu\text{s}$	10	-	-	$V_{CC}=2,000\text{V}$ , $L_S=80\text{nH}$ $R_G(\text{on/off})=2.7/27\Omega$ , $V_{GE}=\pm 15\text{V}$ , $T_{vj}=125^\circ\text{C}$
Turn On Loss	$E_{on(10\%)}$	J/P	-	2.9	3.6	$T_{vj}=125^\circ\text{C}$
	$E_{on(full)}$		-	3.2	-	$T_{vj}=150^\circ\text{C}$
Turn Off Loss	$E_{off(10\%)}$	J/P	-	2.2	2.6	$T_{vj}=125^\circ\text{C}$
	$E_{off(full)}$		-	2.4	-	$T_{vj}=125^\circ\text{C}$
			-	2.5	-	$T_{vj}=150^\circ\text{C}$
			-	2.5	-	$T_{vj}=150^\circ\text{C}$
Reverse Recovery Loss	$E_{rr(10\%)}$	J/P	-	1.4	1.9	$T_{vj}=125^\circ\text{C}$
	$E_{rr(full)}$		-	1.7	-	$T_{vj}=125^\circ\text{C}$
			-	2.1	-	$T_{vj}=150^\circ\text{C}$

Notes: (3)  $R_G$  and  $C_{GE}$  value are a test condition value for evaluation, not recommended value.

Please, determine the suitable  $R_G$  value by measuring switching behaviors.

- \* Please contact our representatives at order.
- \* For improvement, specifications are subject to change without notice.
- \* For actual application, please confirm this spec sheet is the newest revision.

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## THERMAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Thermal Impedance	IGBT	$R_{th(j-c)}$	-	-	0.0078	Junction to case
	FWD	$R_{th(j-c)}$	-	-	0.0156	
Contact Thermal Impedance	$R_{th(c-f)}$	K/W	-	0.005	-	Case to fin

## MODULE MECHANICAL CHARACTERISTICS

Item	Unit	Characteristics	Conditions	
Weight	g	1,300		
Stray inductance in module	LS(CM-EM)	12	Collector-main to Emitter-main	
	LS(ES-EM)	49	Emitter-sense to Emitter-main	
	LS(CM-CS)	56	Collector-main to Collector sense	
Terminal Resistance	$R_{Terminal}$	m $\Omega$	0.09	Collector-main to Emitter-main
Comparative Tracking Index (CTI)	-	600		
Module base plate Material	-	Al-SiC		
Baseplate Thickness	mm	5		
Insulation plate Material	-	AlN		
Terminal Surface treatment	-	Ni plating		
Case Material	-	Poly-Phenylene Sulfide		
Fire and Smoke Category	-	I2 / F3	NFF 16-102	

# MBN1500E33E2

## DEFINITION OF TEST CIRCUIT

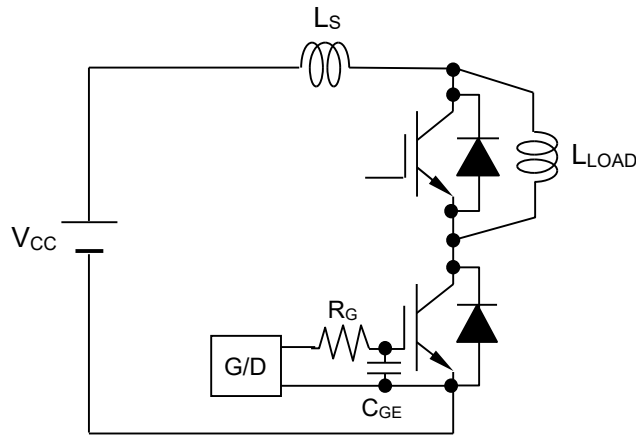


Fig.1 Switching test circuit

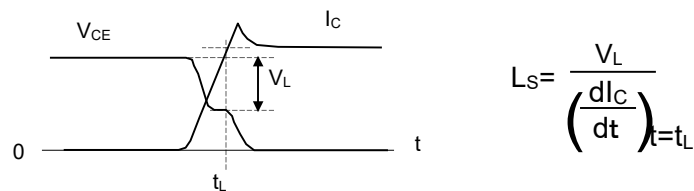


Fig.2 Definition of stray inductance

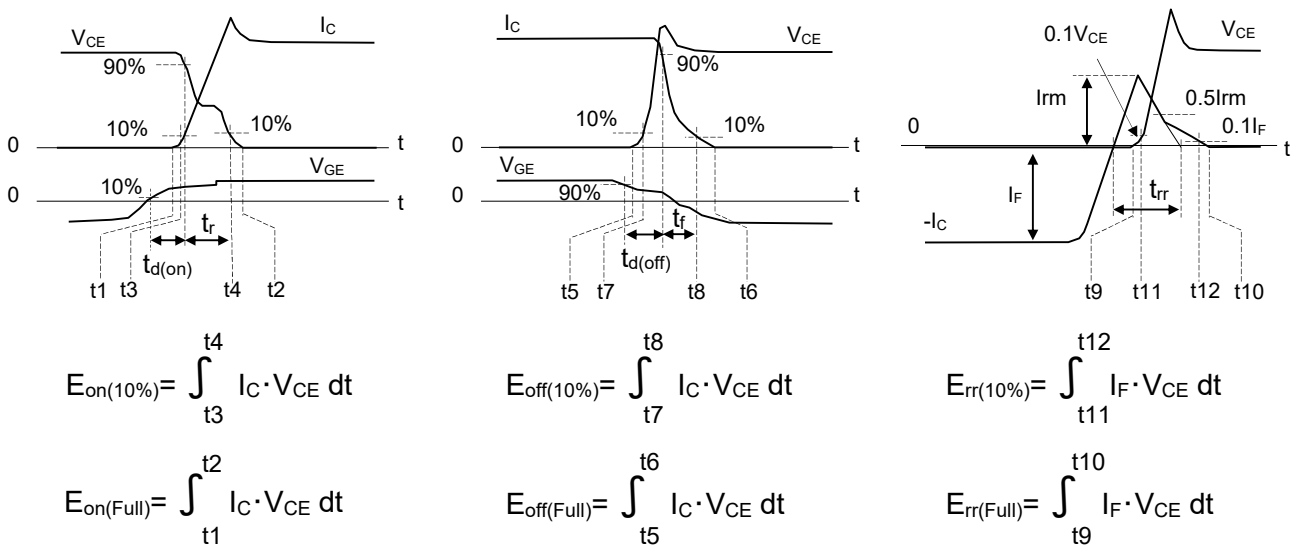
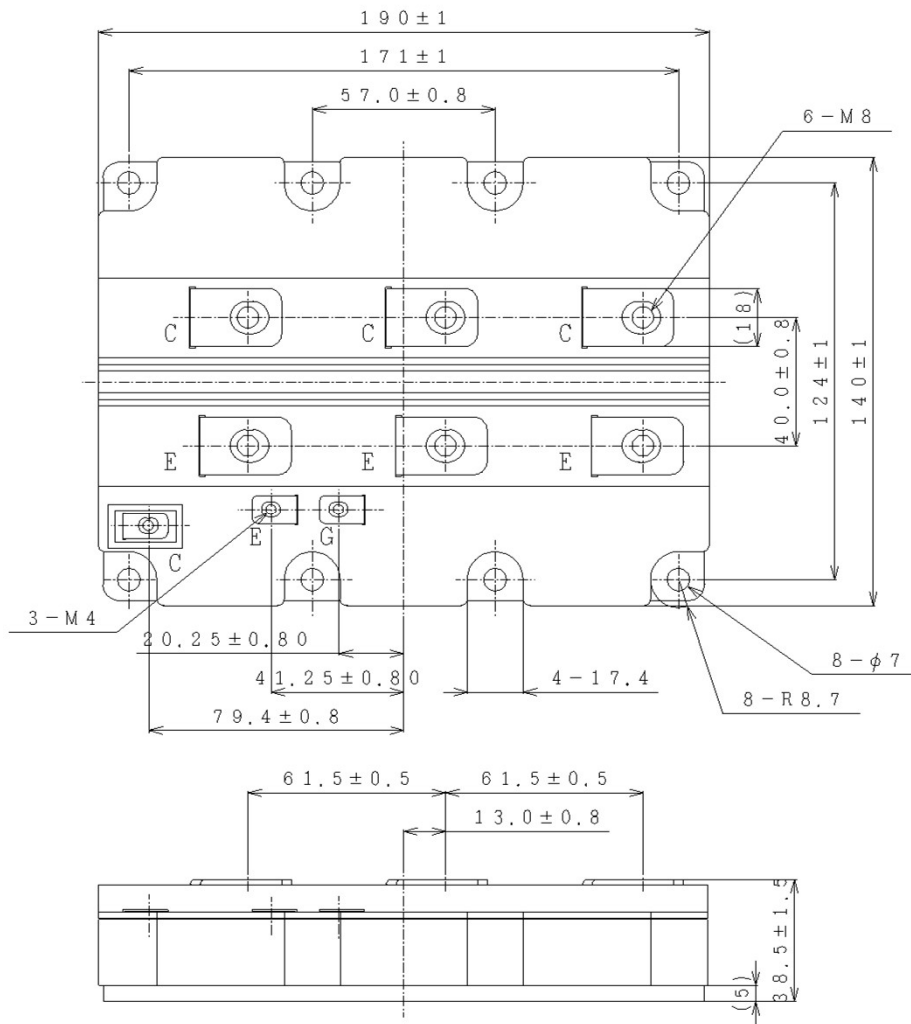


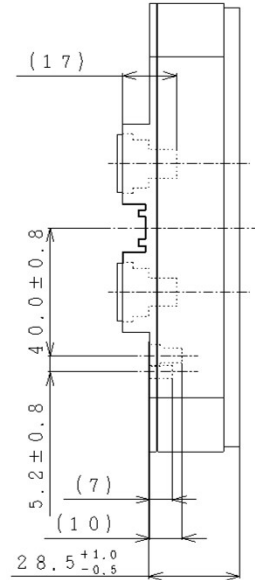
Fig.3 Definition of switching loss

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## OUTLINE DRAWING

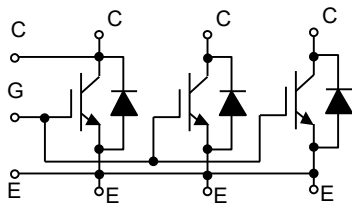


Unit in mm

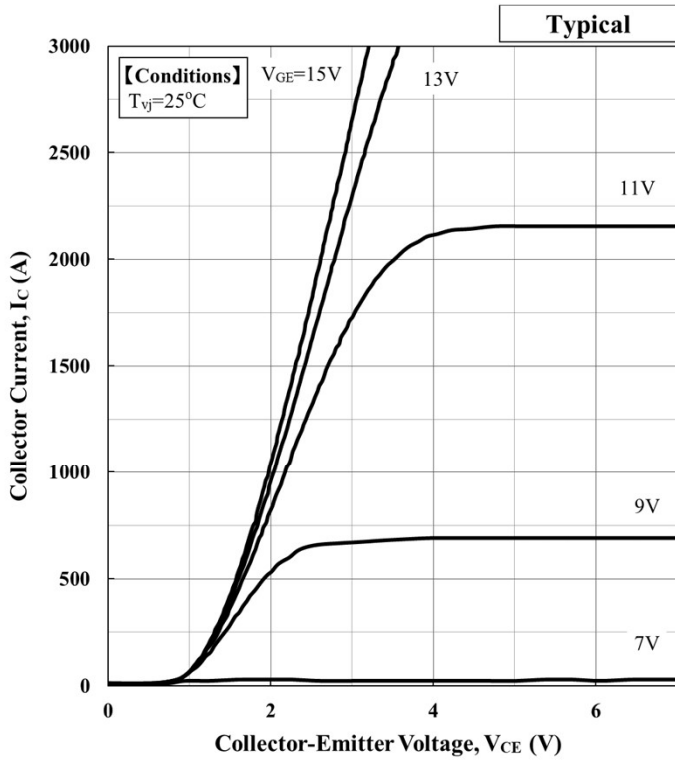


Weight: 1,300g

## CIRCUIT DIAGRAM



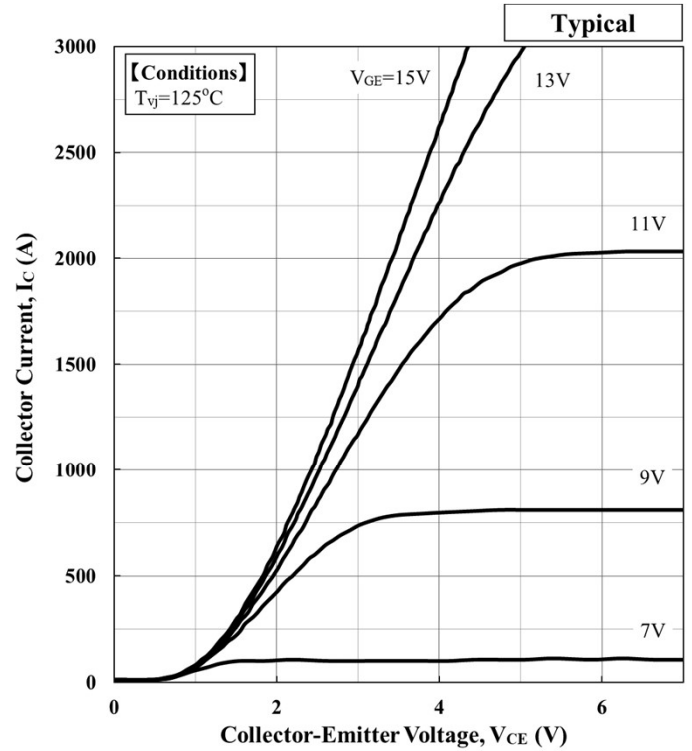
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$$V_{CE(sat)}[V] = a_3 \cdot |I_c|^3 + a_2 \cdot |I_c|^2 + a_1 \cdot |I_c| + a_0$$

Temp.[°C]	V <sub>GE</sub> [V]	a <sub>3</sub>	a <sub>2</sub>	a <sub>1</sub>	a <sub>0</sub>
25	15	3.89E-11	-2.58E-07	1.15E-03	1.04E+00

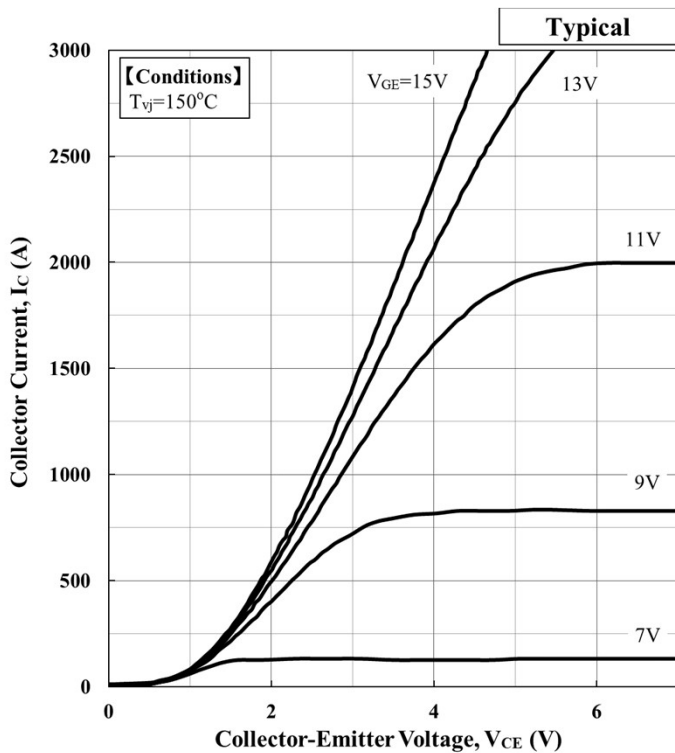
Collector Current vs. Collector Emitter Voltage



$$V_{CE(sat)}[V] = a_3 \cdot |I_c|^3 + a_2 \cdot |I_c|^2 + a_1 \cdot |I_c| + a_0$$

Temp.[°C]	V <sub>GE</sub> [V]	a <sub>3</sub>	a <sub>2</sub>	a <sub>1</sub>	a <sub>0</sub>
125	15	5.71E-11	-3.73E-07	1.71E-03	1.03E+00

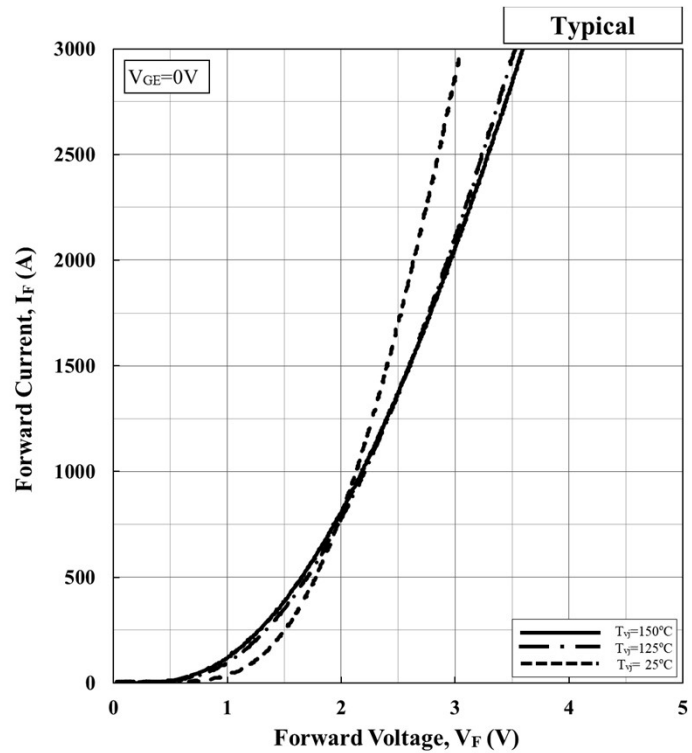
Collector Current vs. Collector Emitter Voltage



$$V_{CE(sat)}[V] = a_3 \cdot |I_c|^3 + a_2 \cdot |I_c|^2 + a_1 \cdot |I_c| + a_0$$

Temp.[°C]	V <sub>GE</sub> [V]	a <sub>3</sub>	a <sub>2</sub>	a <sub>1</sub>	a <sub>0</sub>
150	15	6.33E-11	-4.08E-07	1.87E-03	1.01E+00

Collector Current vs. Collector Emitter Voltage

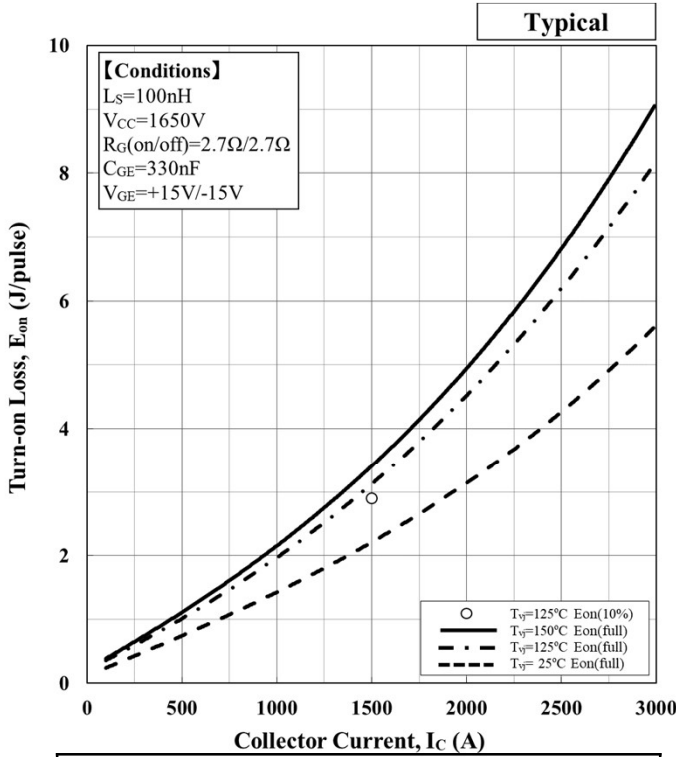


$$V_F[V] = a_3 \cdot |I_F|^3 + a_2 \cdot |I_F|^2 + a_1 \cdot |I_F| + a_0$$

Temp.[°C]	a <sub>3</sub>	a <sub>2</sub>	a <sub>1</sub>	a <sub>0</sub>
25	4.65E-11	-3.30E-07	1.17E-03	1.24E+00
125	5.56E-11	-4.09E-07	1.57E-03	9.85E-01
150	5.80E-11	-4.20E-07	1.64E-03	9.10E-01

Forward Voltage of free-wheeling diode

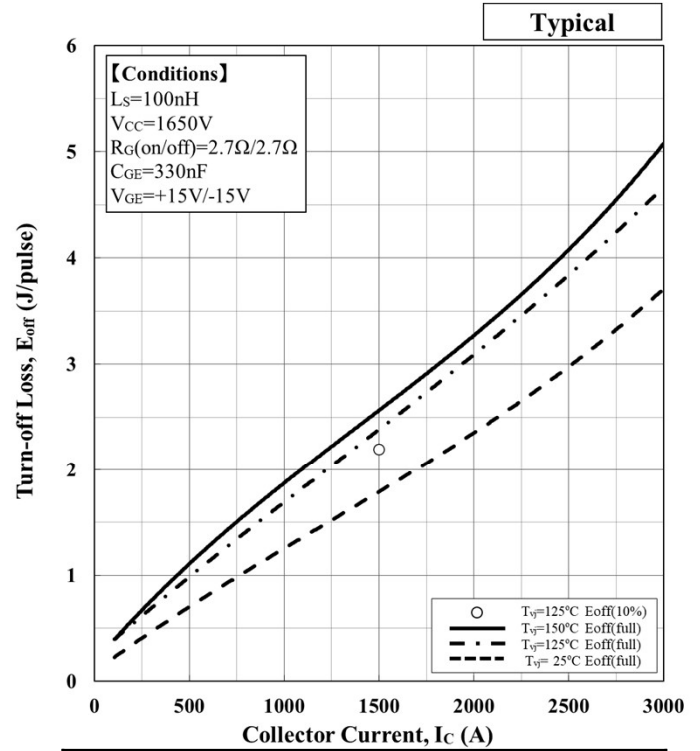
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$$E [J] = a_3 \cdot |I_c|^3 + a_2 \cdot |I_c|^2 + a_1 \cdot |I_c| + a_0$$

Temp.[°C]	$a_3$	$a_2$	$a_1$	$a_0$
25	5.92E-11	2.73E-08	1.22E-03	1.21E-01
125	5.34E-11	2.38E-07	1.46E-03	2.15E-01
150	8.41E-11	1.76E-07	1.67E-03	2.21E-01

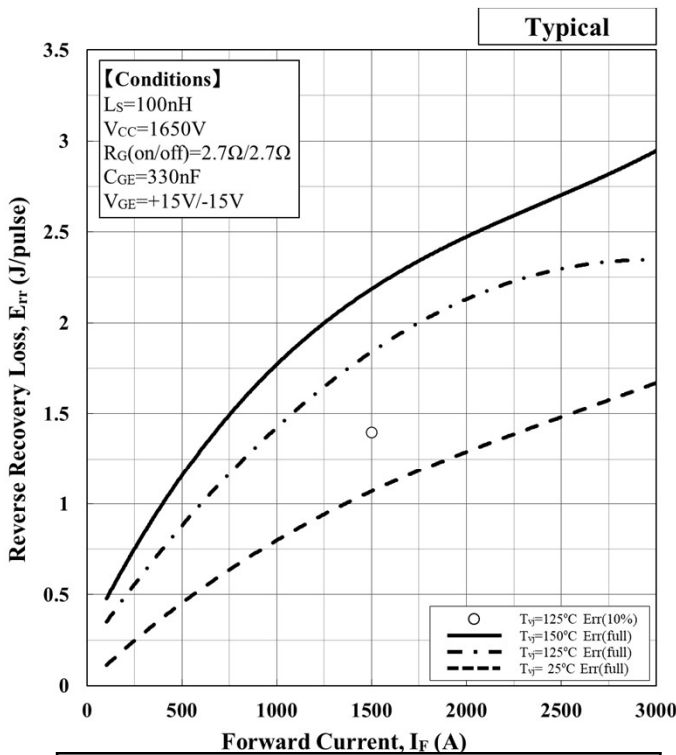
Turn-on loss vs. Collector current



$$E [J] = a_3 \cdot |I_c|^3 + a_2 \cdot |I_c|^2 + a_1 \cdot |I_c| + a_0$$

Temp.[°C]	$a_3$	$a_2$	$a_1$	$a_0$
25	5.45E-11	-1.96E-07	1.30E-03	9.35E-02
125	4.03E-11	-1.52E-07	1.57E-03	2.32E-01
150	1.18E-10	-5.01E-07	2.08E-03	1.81E-01

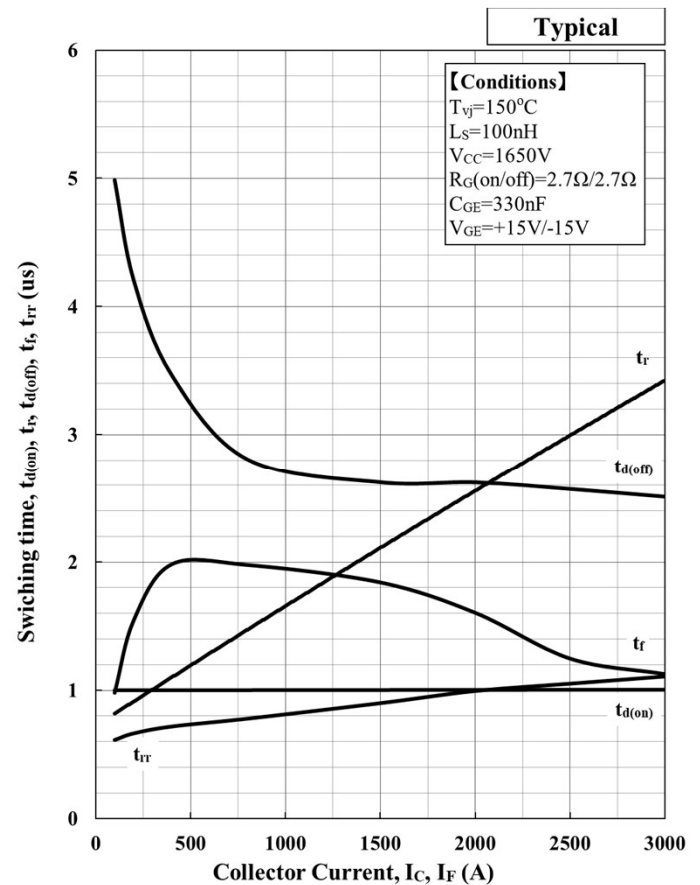
Turn-off loss vs. Collector current



$$E [J] = a_3 \cdot |I_F|^3 + a_2 \cdot |I_F|^2 + a_1 \cdot |I_F| + a_0$$

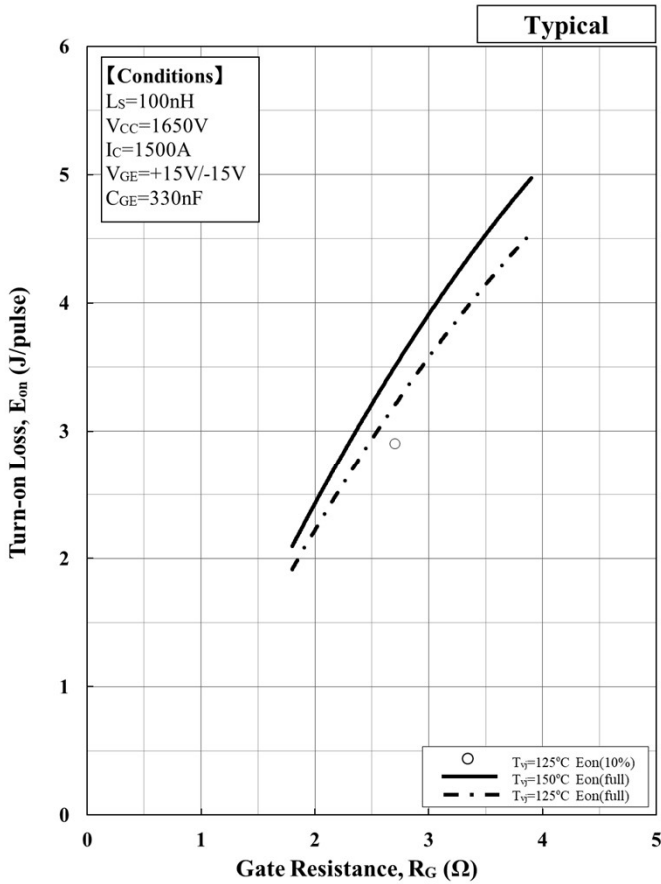
Temp.[°C]	$a_3$	$a_2$	$a_1$	$a_0$
25	3.07E-11	-2.40E-07	9.94E-04	1.33E-02
125	5.10E-12	-2.75E-07	1.50E-03	2.00E-01
150	9.49E-11	-6.84E-07	2.09E-03	2.71E-01

Recovery loss vs. Forward current

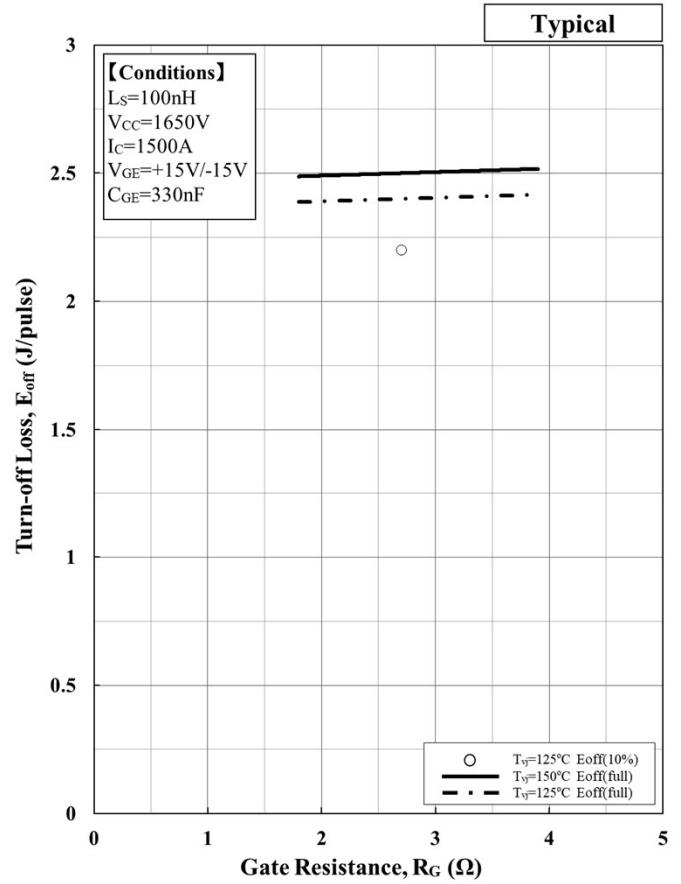


Switching time vs. Collector Current

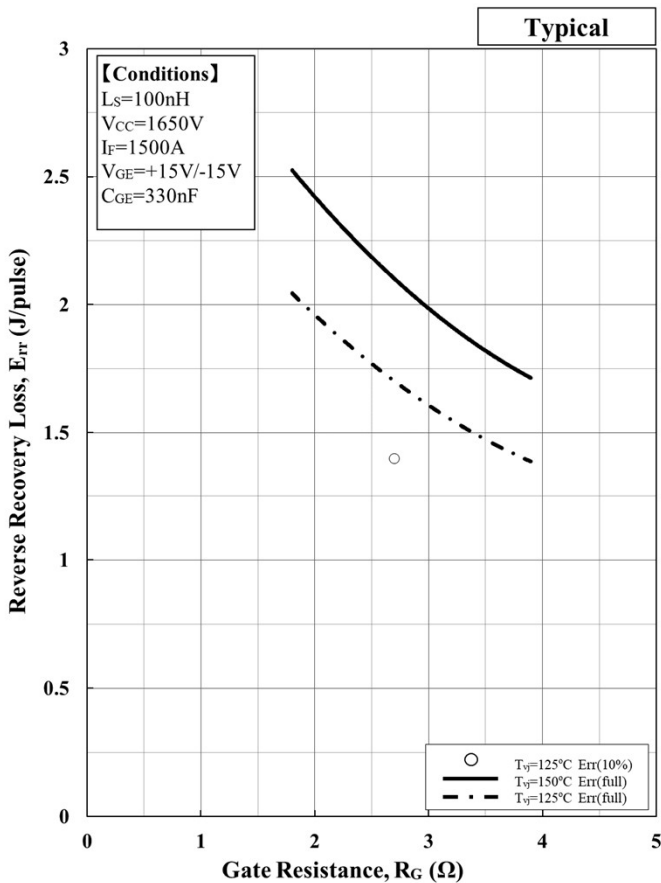
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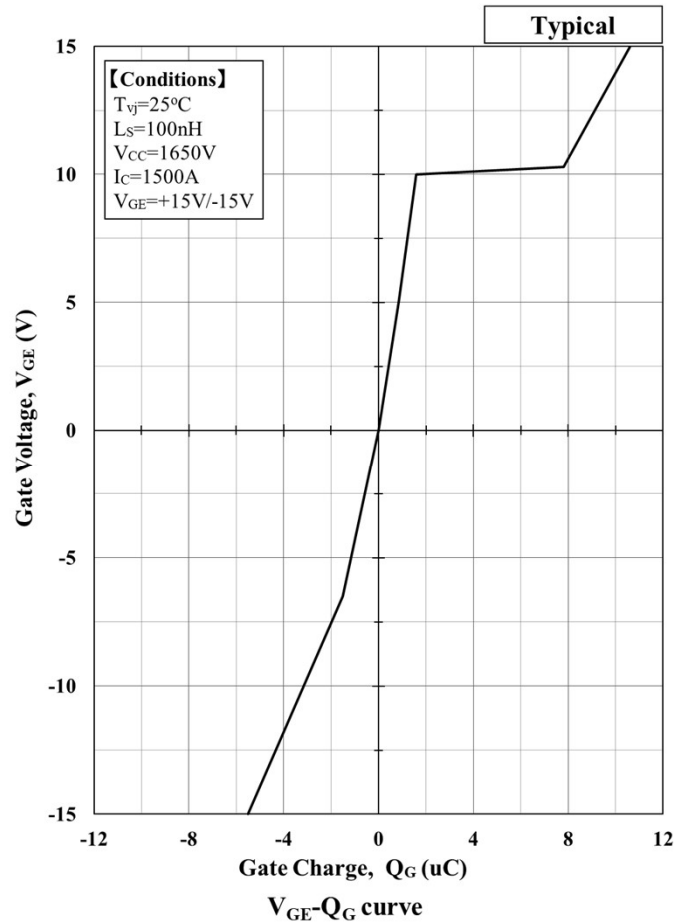
Turn-on loss vs. Gate Resistance



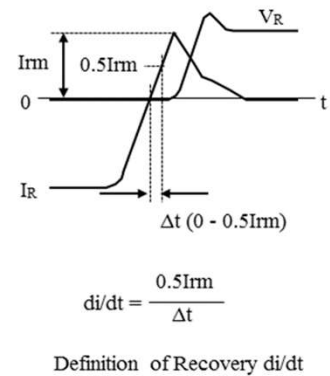
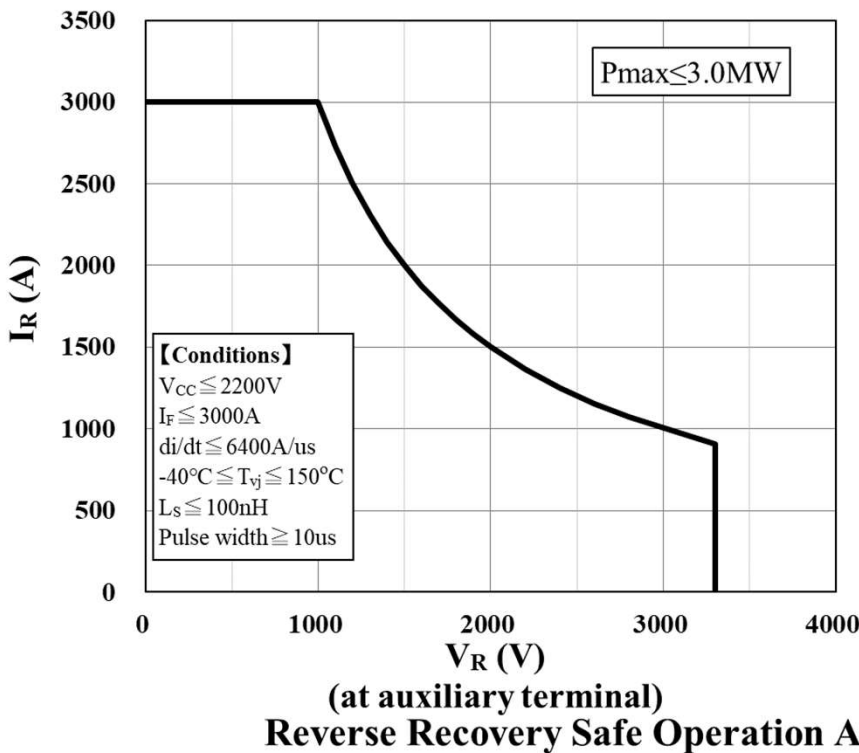
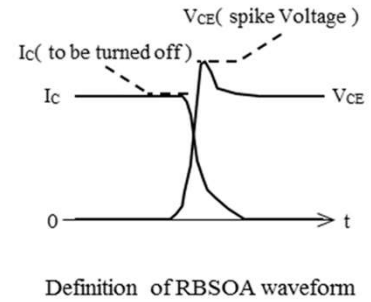
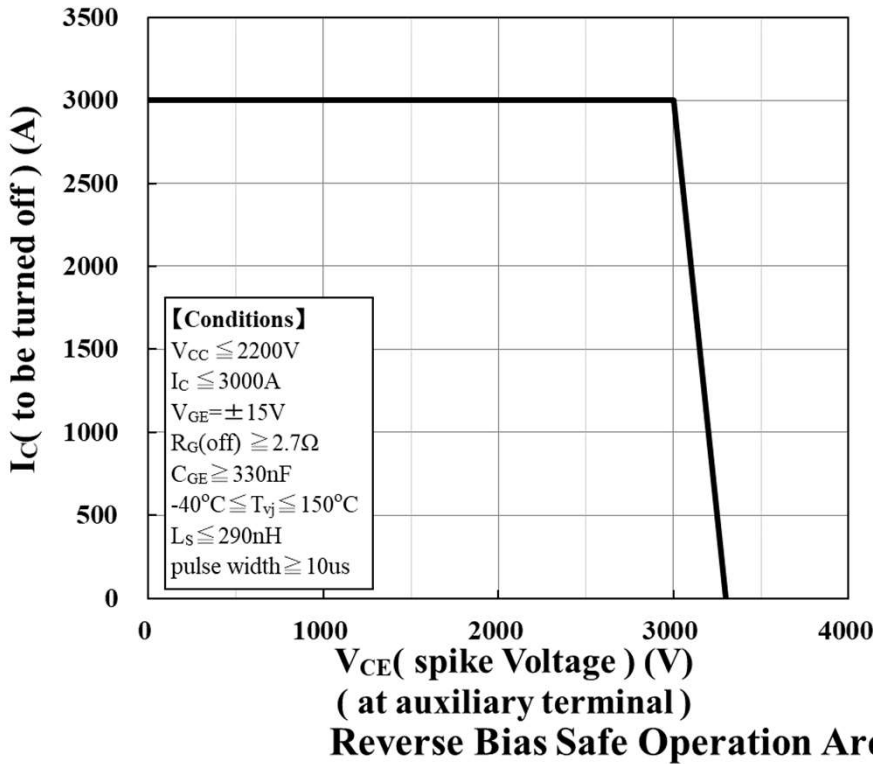
Turn-off loss vs. Gate Resistance



Reverse Recovery loss vs. Gate Resistance

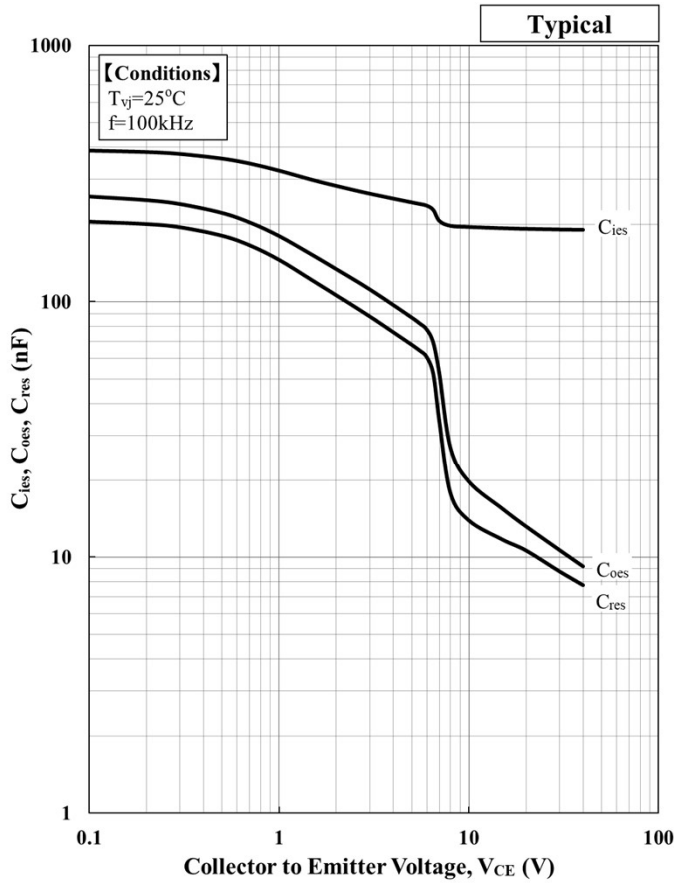


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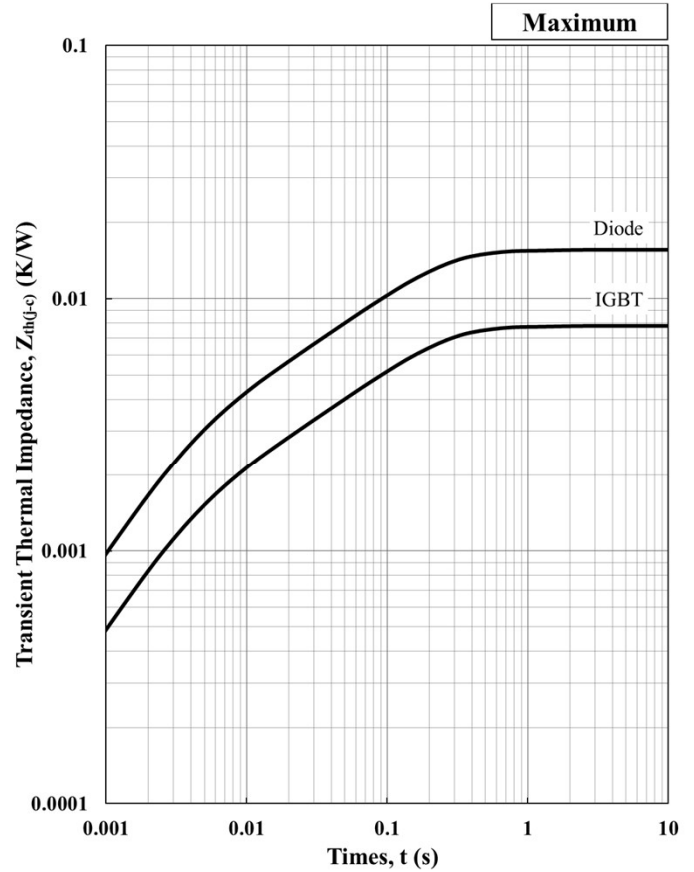




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Capacitance vs. Collector to Emitter Voltage



Transient Thermal Impedance Curve

Foster model lumped circuit constant

n	1	2	3	4
R th, IGBT [n]	4.86E-03	1.40E-03	1.40E-03	1.43E-04
C th, IGBT [n]	3.29E+01	1.95E+01	2.89E+00	5.14E+00
R th, Diode [n]	9.67E-03	2.90E-03	2.74E-03	2.93E-04
C th, Diode [n]	1.65E+01	9.47E+00	1.47E+00	2.51E+00

Cauer model lumped circuit constant

n	1	2	3	4
R th, IGBT [n]	1.10E-03	1.25E-03	2.70E-03	2.75E-03
C th, IGBT [n]	1.61E+00	1.77E+00	1.23E+01	3.64E+01
R th, Diode [n]	2.17E-03	2.52E-03	5.42E-03	5.50E-03
C th, Diode [n]	8.05E-01	8.96E-01	6.04E+00	1.84E+01

Material declaration

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder

# MBN1500E33E2

## HITACHI POWER SEMICONDUCTORS

### Notices

1. Since mishandling of semiconductor devices may cause malfunctions, please be sure to read "Precautions for Safe Use and Notices" in the individual brochure before use.
2. When designing an electronic circuit using semiconductor devices, please do not exceed the absolute maximum rating specified for the device under any external fluctuations. And for pulse applications, please also do not exceed the "Safe Operating Area (SOA)".
3. Semiconductor devices may sometimes break down by accidental or unexpected surge voltage, so please be careful about the safety design such as redundant design and malfunction prevention design which don't cause the damage expand even if they break down.
4. In cases where extremely high reliability is required (such as use in nuclear power control, aerospace and aviation, traffic equipment, life-support-related medical equipment, fuel control equipment and various kinds of safety equipment), safety should be ensured by using semiconductor devices that feature assured safety or by means of users' fail-safe precautions or other arrangement. Or consult with Hitachi's sales department staff. (When semiconductor devices fail, as a result the semiconductor devices or wiring, wiring pattern may smoke, ignite, or the semiconductor devices themselves may burst.)
5. A semi-processed article is done now using solder which contains lead inside the semiconductor devices. There is possibility of the regulation substance depend on the applied models, so please check before using.
6. This specification is a material for component selection, which describes specifications of power semiconductor devices (hereinafter referred to as products), characteristic charts, and external dimension drawings.
7. The information given herein, including the specifications and dimensions, is subject to change without prior notice to improve product characteristics. Before ordering, purchasers are advised to contact with Hitachi power semiconductor sales department for the latest version of this data sheets.
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# MBN1500E33E2

## HITACHI POWER SEMICONDUCTORS

### Usage

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